

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Nadeem N. Eleyan et al.

Title: Test Circuit for Measuring Sense Amplifier and Memory Mismatches

Application No.: 10/683,636 Filed: October 10, 2003

Examiner: Thong Quoc Le Group Art Unit: 2827

Atty. Docket No.: 004-30059 Confirmation No.: 1191

June 26, 2006

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

RESPONSE TO NON-FINAL OFFICE ACTION

This paper is responsive to the Non-Final Office Action mailed on May 1, 2006, having a shortened statutory period for response set to expire August 1, 2006. In light of the Amendments and/or Remarks herein, further examination is requested.

Any fees required by this paper are being provided as directed in an electronic submission of this paper or in a transmittal letter accompanying this paper. However, the Commissioner is hereby authorized to charge any deficiency in fees required by this paper and any additional fees under 37 C.F.R. § 1.16 or 1.17 which may be required during the pendency of this application, and to similarly credit any overpayment, to Deposit Account 50-0631.